

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination SHEN ET AL.	
			Examiner Shelly A. Chase	Art Unit 2133	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Chen et al., Reduced-complexity decoding of LDPC Codes, 2002, IEEE, pg. 1 to 31.
	V	Yu-Hu et al. Efficient implementations of the Sum-product algorithm for decoding LDPC codes, 2001, IEEE, pg. 1036-1036E
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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